Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/742,919	LEE ET AL.	
Examiner	Art Unit	
Tai Duong	2871	

SEARCHED				
Class	Subclass	Date	Examiner	
349	110	8/21/2006	TD	
	111			
	141			
	153			
	156			
	190			
430	20			
	321			
		•	<b>1</b>	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST (US PGPUB, USPAT, EPO, JPO, DERWENT, IBM TDB) see search history printout	8/21/2006	ΤD	
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